Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/530,066	KAIN, ARON ZEV	
Examiner	Art Unit	

William Oen

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Class	Subclass	Date	Examiner
73	146 146.5 715-728 753	11/22/2005	wo
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
Same as	Above	11/22/2005	wo	
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	DATE	EXMR	
EAST	11/22/200	5 WO	